

PMZ760SN

μ TrenchMOS™ standard level FET

Rev. 01 — 24 February 2003

Objective data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

Product availability:

PMZ760SN in SOT883.

1.2 Features

- Profile 55% lower than SOT23
- Low on-state resistance
- Footprint 90% smaller than SOT23
- Fast switching.

1.3 Applications

- Driver circuits
- Switching in portable appliances.

1.4 Quick reference data

- $V_{DS} \leq 60$ V
- $I_D \leq <tbid> A$
- $P_{tot} \leq <tbid> W$
- $R_{DSon} \leq 900$ m Ω .

2. Pinning information

Table 1: Pinning - SOT883, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)	<p>bottom view MGX357</p> <p>SOT883</p>	<p>MBB076</p>
2	source (s)		
3	drain (d)		



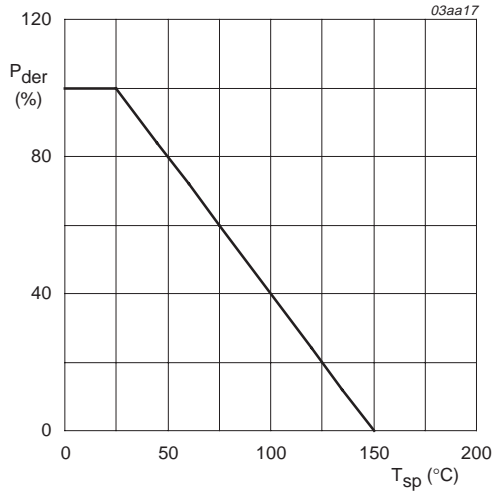
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3. Limiting values

Table 2: Limiting values

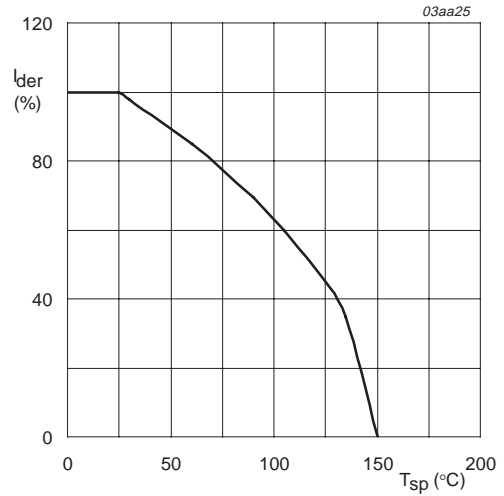
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	60	V
V_{DGR}	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	60	V
V_{GS}	gate-source voltage (DC)		-	± 20	V
I_D	drain current (DC)	$T_{sp} = 25\text{ °C}$; $V_{GS} = 10\text{ V}$; Figure 2 and 3	-	<td>	A
		$T_{sp} = 100\text{ °C}$; $V_{GS} = 10\text{ V}$; Figure 2	-	<td>	A
I_{DM}	peak drain current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; Figure 3	-	<td>	A
P_{tot}	total power dissipation	$T_{sp} = 25\text{ °C}$; Figure 1	-	<td>	W
T_{stg}	storage temperature		-55	+150	°C
T_j	junction temperature		-55	+150	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	$T_{sp} = 25\text{ °C}$	-	<td>	A
I_{SM}	peak source (diode forward) current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	<td>	A



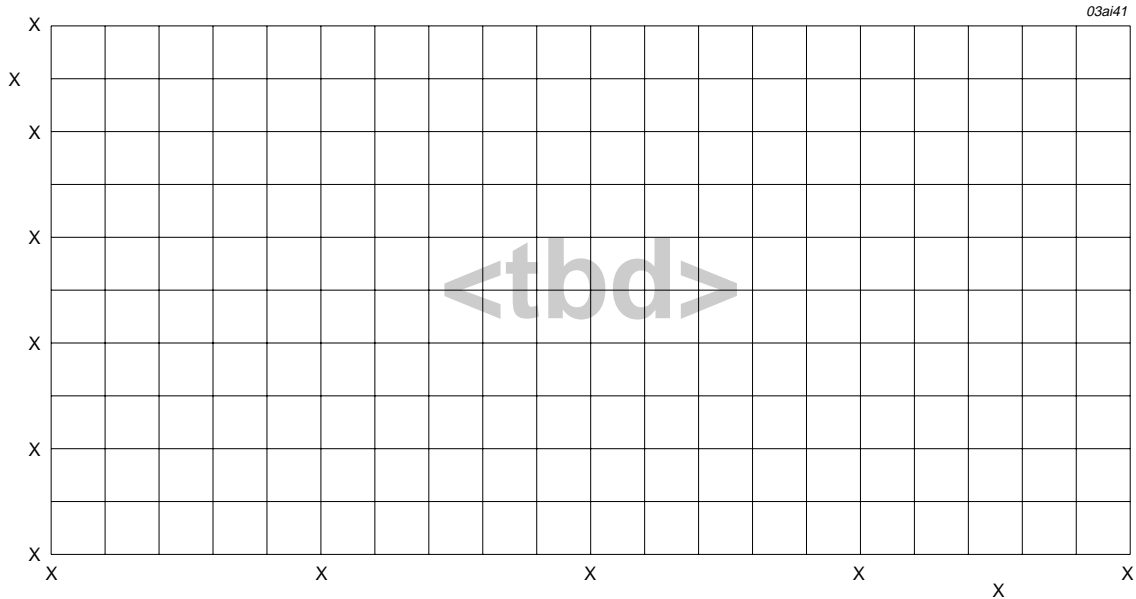
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature.



T_{sp} = 25 °C; I_{DM} is single pulse; V_{GS} = 10 V.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	Figure 4	-	-	<td>	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	<td>	-	K/W

4.1 Transient thermal impedance

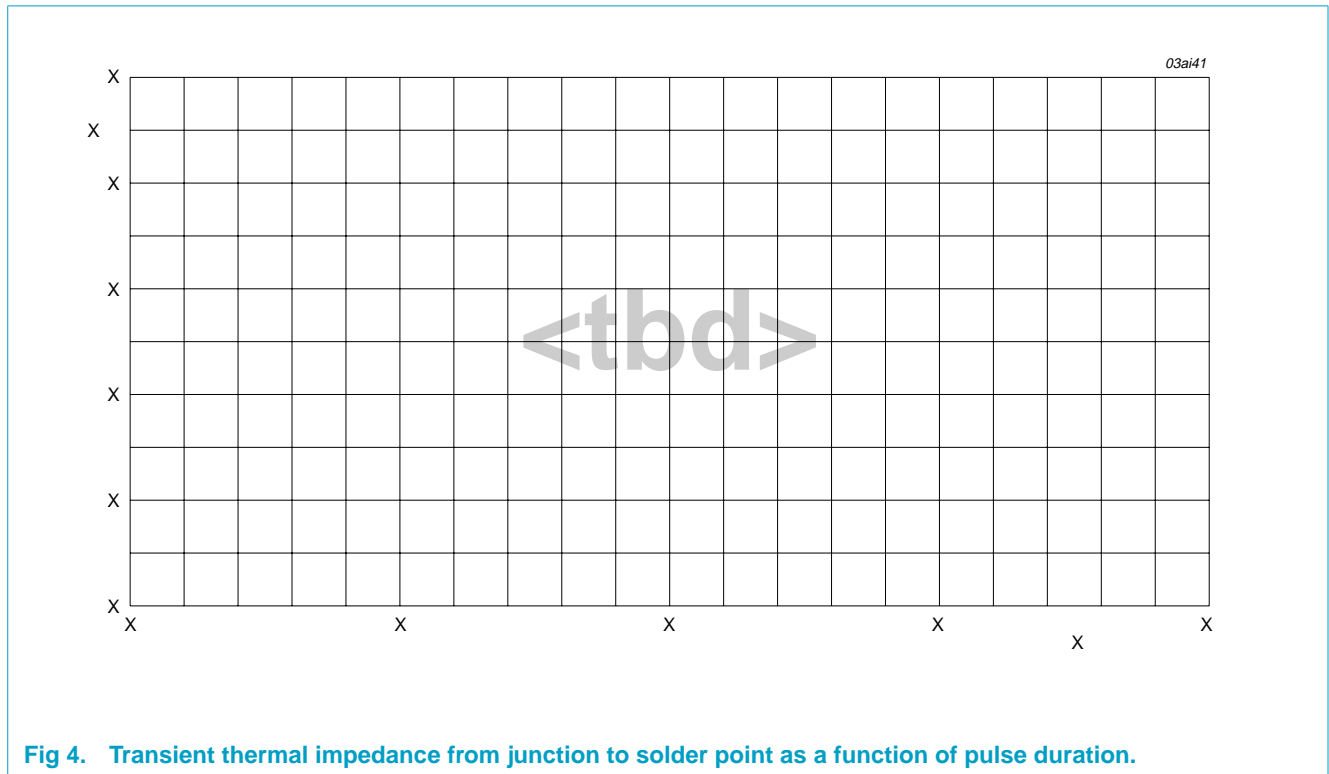
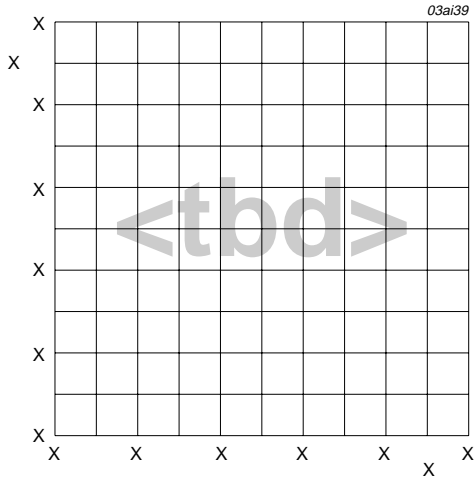


Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration.

5. Characteristics

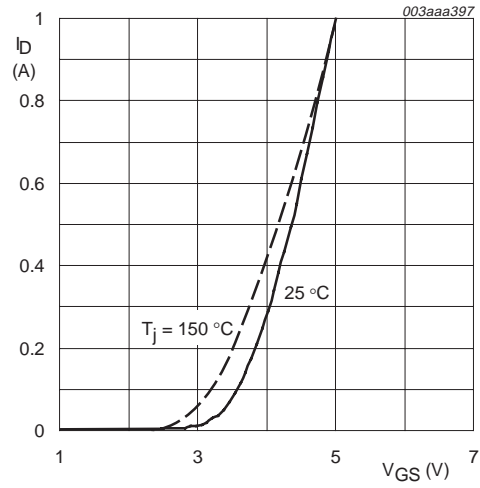
Table 4: Characteristics
 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 1\text{ }\mu\text{A}$; $V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^\circ\text{C}$	60	-	-	V
		$T_j = -55\text{ }^\circ\text{C}$	55	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.25\text{ mA}$; $V_{DS} = V_{GS}$; Figure 9				V
		$T_j = 25\text{ }^\circ\text{C}$	1	2	3	V
		$T_j = 150\text{ }^\circ\text{C}$	0.5	-	-	V
		$T_j = -55\text{ }^\circ\text{C}$	-	-	3.4	V
I_{DSS}	drain-source leakage current	$V_{DS} = 60\text{ V}$; $V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^\circ\text{C}$	-	0.05	1	μA
		$T_j = 100\text{ }^\circ\text{C}$	-	-	100	μA
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 20\text{ V}$; $V_{DS} = 0\text{ V}$	-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}$; $I_D = 0.3\text{ A}$; Figure 7 and 8 $T_j = 25\text{ }^\circ\text{C}$	-	760	900	m Ω
		$T_j = 150\text{ }^\circ\text{C}$	-	1255	1665	m Ω
		$V_{GS} = 4.5\text{ V}$; $I_D = 0.075\text{ A}$; Figure 7	-	960	1200	m Ω
Dynamic characteristics						
$Q_{g(tot)}$	total gate charge	$I_D = 0.5\text{ A}$; $V_{DD} = 40\text{ V}$; $V_{GS} = 10\text{ V}$; Figure 13	-	1.2	-	nC
Q_{gs}	gate-source charge		-	0.2	-	nC
Q_{gd}	gate-drain (Miller) charge		-	0.35	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\text{ V}$; $V_{DS} = 30\text{ V}$; $f = 1\text{ MHz}$; Figure 11	-	3.9	-	pF
C_{oss}	output capacitance		-	6.6	-	pF
C_{rss}	reverse transfer capacitance		-	33	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 50\text{ V}$; $I_D = 0.2\text{ A}$; $V_{GS} = 10\text{ V}$; $R_G = 4.7\text{ }\Omega$	-	2.1	-	ns
t_r	rise time		-	2.4	-	ns
$t_{d(off)}$	turn-off delay time		-	6.3	-	ns
t_f	fall time		-	3.8	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 0.3\text{ A}$; $V_{GS} = 0\text{ V}$; Figure 12	-	0.8	1.2	V



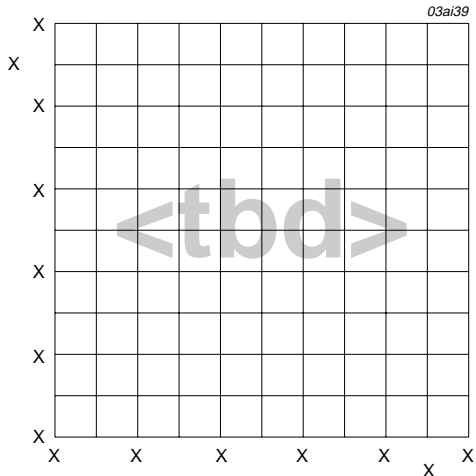
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



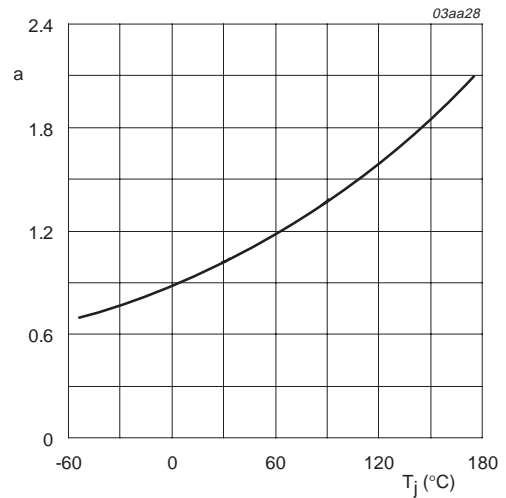
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



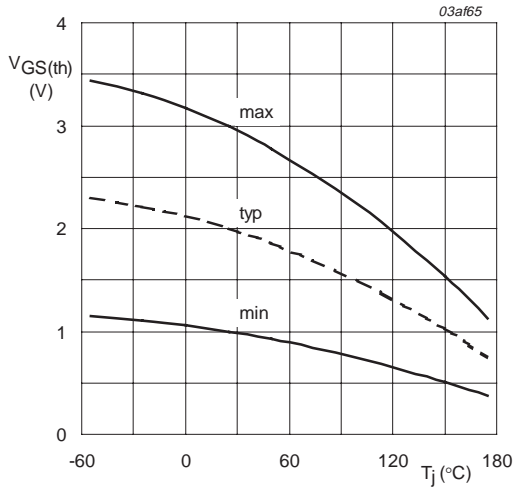
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



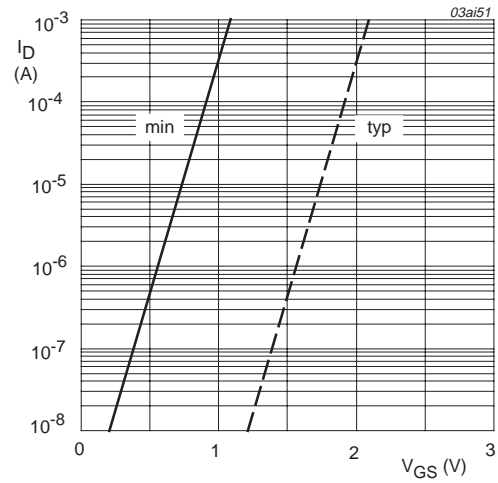
$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



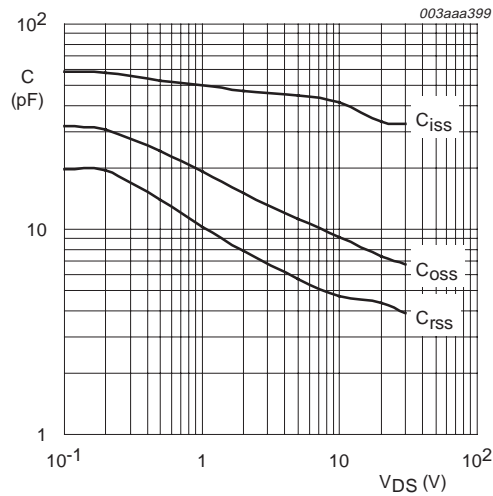
$I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



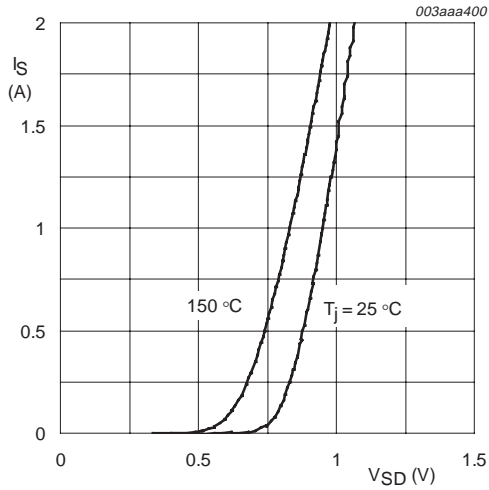
$T_j = 25 \text{ }^{\circ}C; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



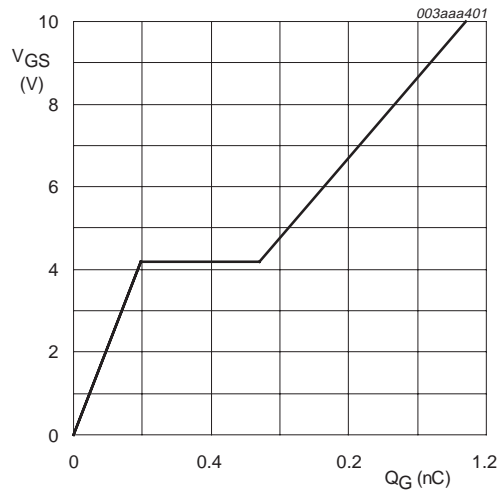
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25\text{ °C}$ and 150 °C ; $V_{GS} = 0\text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 0.5\text{ A}$; $V_{DD} = 40\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.

6. Package outline

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm

SOT883

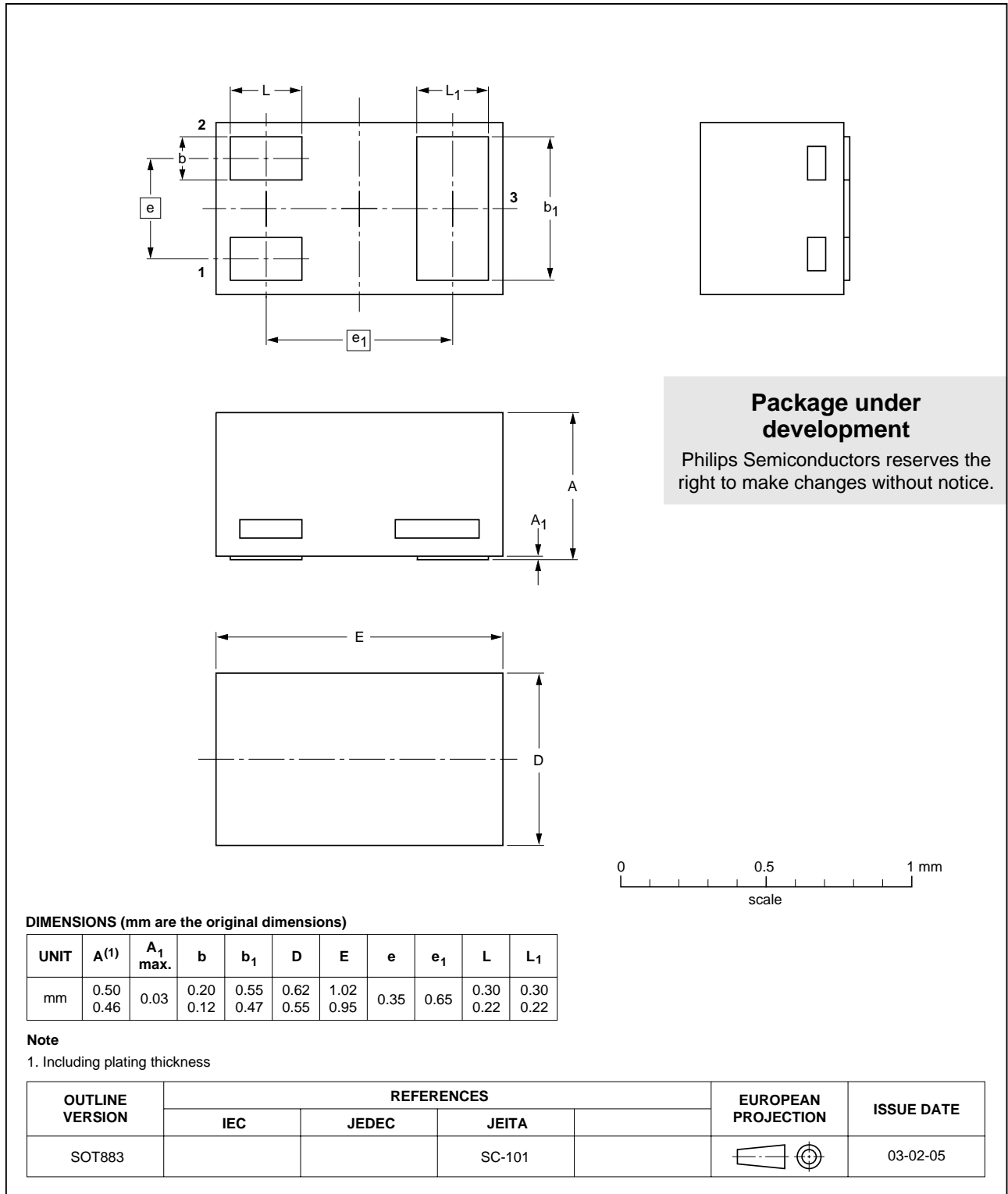
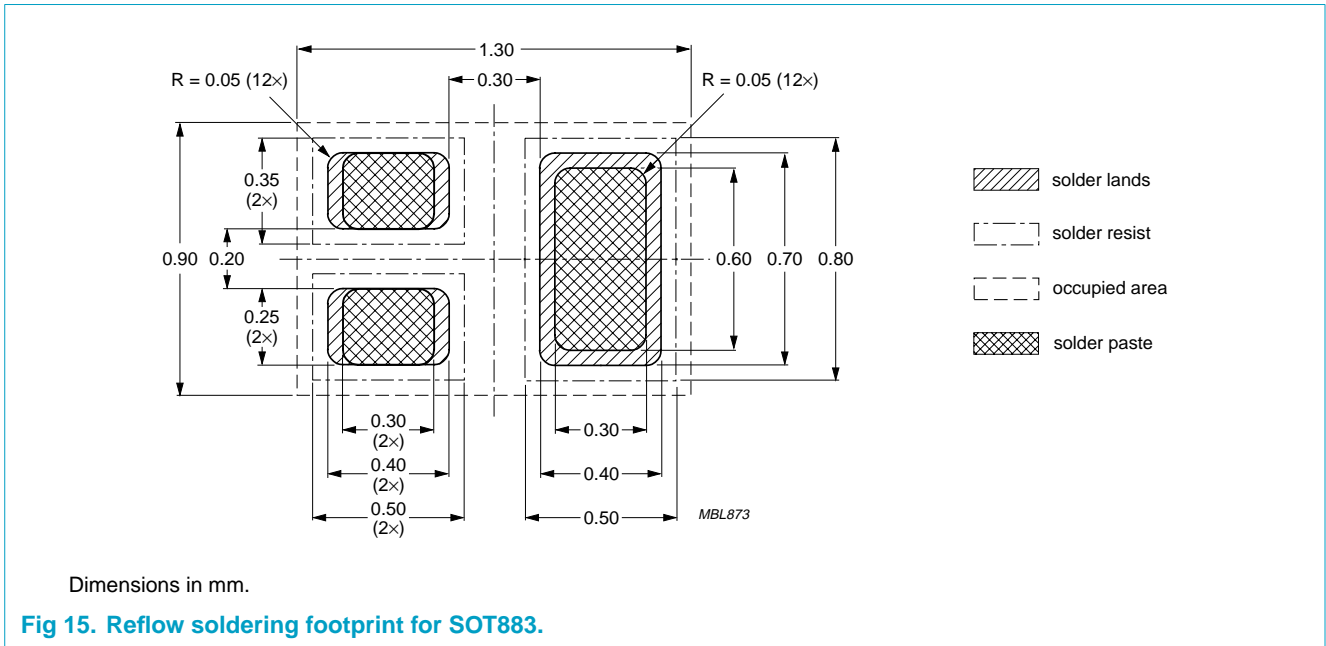


Fig 14. SOT883.

7. Soldering



8. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
01	20030224	-	Objective data (9397 750 11143)

9. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Contents

1	Product profile	1
1.1	Description	1
1.2	Features	1
1.3	Applications	1
1.4	Quick reference data	1
2	Pinning information	1
3	Limiting values	2
4	Thermal characteristics	4
4.1	Transient thermal impedance	4
5	Characteristics	5
6	Package outline	9
7	Soldering	10
8	Revision history	10
9	Data sheet status	11
10	Definitions	11
11	Disclaimers	11
12	Trademarks	11

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